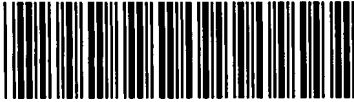


**Search Notes****Application/Control No.**

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**Examiner**

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Reexamination**

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Double Patent Check NEW Data Bases Search (see search history printout(s))	11/26/2007	MAI